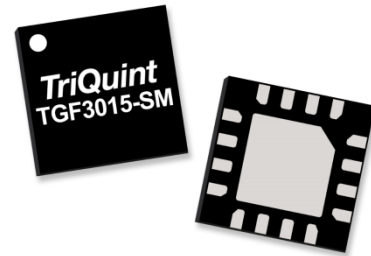


Applications

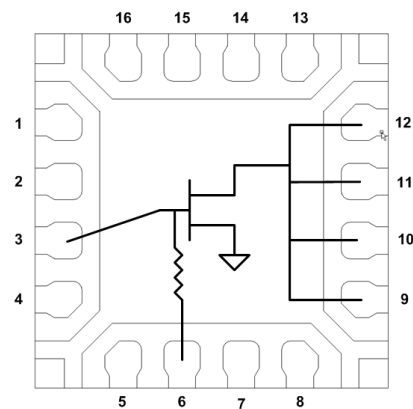
- Military radar
- Civilian radar
- Land mobile and military radio communications
- Test instrumentation
- Wideband or narrowband amplifiers
- Jammers



Product Features

- Frequency: 30 MHz to 3.0 GHz
- Output Power (P_{3dB}): 11 W at 2.4 GHz
- Linear Gain: 17.1 dB at 2.4 GHz
- Typical PAE_{3dB} : 62.7% at 2.4 GHz
- Operating Voltage: 32 V
- Low thermal resistance package
- CW and Pulse capable
- 3 x 3 mm package

Functional Block Diagram



General Description

The TriQuint TGF3015-SM is a 10W (P_{3dB}), 50 Ω -input matched discrete GaN on SiC HEMT which operates from 30MHz to 3.0 GHz. The integrated input matching network enables wideband gain and power performance, while the output can be matched on board to optimize power and efficiency for any region within the band.

The device is housed in an industry-standard 3 x 3 mm package that saves real estate of already space-constrained handheld radios.

Lead-free and ROHS compliant

Evaluation boards are available upon request.

Pin Configuration

| Pin No. | Label |
|-----------|---|
| 9 - 12 | V_D / RF OUT |
| 3 | V_G / RF IN |
| 6 | Off-chip Shunt Cap for Low-Frequency Gain |
| Back side | Source |

Ordering Information

| Part | ECCN | Description |
|-----------------|-------|-------------------|
| TGF3015-SM | EAR99 | QFN Packaged Part |
| TGF3015-SM-EVB1 | EAR99 | 0.5 – 3 GHz EVB |

Absolute Maximum Ratings

| Parameter | Value |
|---|----------------|
| Breakdown Voltage (V_{DG}) | 100 V min. |
| Gate Voltage Range (V_G) | -50 to 0 V |
| Drain Current (I_D) | 1.5 A |
| Gate Current (I_G) | -2.5 to 4.2 mA |
| Power Dissipation (P_D) | 15 W |
| RF Input Power, CW, $T = 25^\circ\text{C}$ (P_{IN}) | 27.5 dBm |
| Channel Temperature (T_{CH}) | 275 °C |
| Mounting Temperature (30 Seconds) | 320 °C |
| Storage Temperature | -40 to 150 °C |

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

Recommended Operating Conditions

| Parameter ¹ | Value |
|---|---------------|
| Drain Voltage (V_D) | 32 V (Typ.) |
| Drain Quiescent Current (I_{DQ}) | 50 mA (Typ.) |
| Peak Drain Current (I_D) | 557 mA (Typ.) |
| Gate Voltage (V_G) | -2.7 V (Typ.) |
| Channel Temperature (T_{CH}) | 225 °C (Max) |
| Power Dissipation, CW (P_D) | 9.9 W (Max) |
| Power Dissipation, Pulse (P_D) ² | 15.3 W (Max) |

¹ Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

² 100uS Pulse Width, 20% Duty Cycle

RF Characterization – Load Pull Performance at 1.0 GHz

Test conditions unless otherwise noted: $T_A = 25^\circ\text{C}$, $V_D = 32\text{ V}$, $I_{DQ} = 50\text{ mA}$, Pulse: 100uS Pulse Width, 20% Duty Cycle

| Symbol | Parameter | Min | Typical | Max | Units |
|-------------|---|-----|---------|-----|-------|
| G_{LIN} | Linear Gain, Power Tuned | | 16.2 | | dB |
| P_{3dB} | Output Power at 3 dB Gain Compression, Power Tuned | | 40.2 | | dBm |
| PAE_{3dB} | Power-Added Efficiency at 3 dB Gain Compression, Efficiency Tuned | | 70.9 | | % |
| G_{3dB} | Gain at 3 dB Compression, Power Tuned | | 13.2 | | dB |

RF Characterization – Load Pull Performance at 2.0 GHz

Test conditions unless otherwise noted: $T_A = 25^\circ\text{C}$, $V_D = 32\text{ V}$, $I_{DQ} = 50\text{ mA}$, Pulse: 100uS Pulse Width, 20% Duty Cycle

| Symbol | Parameter | Min | Typical | Max | Units |
|-------------|---|-----|---------|-----|-------|
| G_{LIN} | Linear Gain, Power Tuned | | 16.5 | | dB |
| P_{3dB} | Output Power at 3 dB Gain Compression, Power Tuned | | 40.6 | | dBm |
| PAE_{3dB} | Power-Added Efficiency at 3 dB Gain Compression, Efficiency Tuned | | 61.7 | | % |
| G_{3dB} | Gain at 3 dB Compression, Power Tuned | | 13.5 | | dB |

RF Characterization – Load Pull Performance at 2.4 GHz

Test conditions unless otherwise noted: $T_A = 25\text{ }^\circ\text{C}$, $V_D = 32\text{ V}$, $I_{DQ} = 50\text{ mA}$, Pulse: 100uS Pulse Width, 20% Duty Cycle

| Symbol | Parameter | Min | Typical | Max | Units |
|-------------|---|-----|---------|-----|-------|
| G_{LIN} | Linear Gain, Power Tuned | | 17.1 | | dB |
| P_{3dB} | Output Power at 3 dB Gain Compression, Power Tuned | | 40.4 | | dBm |
| PAE_{3dB} | Power-Added Efficiency at 3 dB Gain Compression, Efficiency Tuned | | 62.7 | | % |
| G_{3dB} | Gain at 3 dB Compression, Power Tuned | | 14.1 | | dB |

RF Characterization – Load Pull Performance at 2.7 GHz

Test conditions unless otherwise noted: $T_A = 25\text{ }^\circ\text{C}$, $V_D = 32\text{ V}$, $I_{DQ} = 50\text{ mA}$, Pulse: 100uS Pulse Width, 20% Duty Cycle

| Symbol | Parameter | Min | Typical | Max | Units |
|-------------|---|-----|---------|-----|-------|
| G_{LIN} | Linear Gain, Power Tuned | | 16.3 | | dB |
| P_{3dB} | Output Power at 3 dB Gain Compression, Power Tuned | | 40.5 | | dBm |
| PAE_{3dB} | Power-Added Efficiency at 3 dB Gain Compression, Efficiency Tuned | | 63.7 | | % |
| G_{3dB} | Gain at 3 dB Compression, Power Tuned | | 13.3 | | dB |

RF Characterization – Load Pull Performance at 3.0 GHz

Test conditions unless otherwise noted: $T_A = 25\text{ }^\circ\text{C}$, $V_D = 32\text{ V}$, $I_{DQ} = 50\text{ mA}$, Pulse: 100uS Pulse Width, 20% Duty Cycle

| Symbol | Parameter | Min | Typical | Max | Units |
|-------------|---|-----|---------|-----|-------|
| G_{LIN} | Linear Gain, Power Tuned | | 15.4 | | dB |
| P_{3dB} | Output Power at 3 dB Gain Compression, Power Tuned | | 40.5 | | dBm |
| PAE_{3dB} | Power-Added Efficiency at 3 dB Gain Compression, Efficiency Tuned | | 58.6 | | % |
| G_{3dB} | Gain at 3 dB Compression, Power Tuned | | 12.4 | | dB |

RF Characterization – EVB Performance at 2.4 GHz

Test conditions unless otherwise noted: $T_A = 25\text{ }^\circ\text{C}$, $V_D = 32\text{ V}$, $I_{DQ} = 50\text{ mA}$, Pulse: 100uS Pulse Width, 20% Duty Cycle

| Symbol | Parameter | Min | Typical | Max | Units |
|------------|---|-----|---------|-----|-------|
| G_{LIN} | Linear Gain | | 17.0 | | dB |
| P_{3dB} | Output Power at 3 dB Gain Compression | | 9.3 | | W |
| DE_{3dB} | Drain Efficiency at 3 dB Gain Compression | | 50.7 | | % |
| G_{3dB} | Gain at 3 dB Compression | | 14.0 | | dB |

RF Characterization – Mismatch Ruggedness at 3.0 GHz

Test conditions unless otherwise noted: $T_A = 25\text{ }^\circ\text{C}$, $V_D = 32\text{ V}$, $I_{DQ} = 50\text{ mA}$

Driving input power is determined at 3dB Pulsed compression under matched condition at EVB output connector.

| Symbol | Parameter | Typical |
|--------|-------------------------------|---------|
| VSWR | Impedance Mismatch Ruggedness | 10:1 |

Thermal and Reliability Information - CW ¹

| Parameter | Test Conditions | Value | Units |
|--------------------------------------|----------------------------|---------|-----------------------------|
| Thermal Resistance (θ_{JC}) | Vds = 32V, Idq = 50mA | 11.6 | $^{\circ}\text{C}/\text{W}$ |
| Channel Temperature (T_{CH}) | 85 $^{\circ}\text{C}$ Case | 114 | $^{\circ}\text{C}$ |
| Median Lifetime (T_M) | 2.5 W Pdiss, CW | 2.15E11 | Hrs |
| Thermal Resistance (θ_{JC}) | Vds = 32V, Idq = 50mA | 12.2 | $^{\circ}\text{C}/\text{W}$ |
| Channel Temperature (T_{CH}) | 85 $^{\circ}\text{C}$ Case | 146 | $^{\circ}\text{C}$ |
| Median Lifetime (T_M) | 5 W Pdiss, CW | 3.89E9 | Hrs |
| Thermal Resistance (θ_{JC}) | Vds = 32V, Idq = 50mA | 13.1 | $^{\circ}\text{C}/\text{W}$ |
| Channel Temperature (T_{CH}) | 85 $^{\circ}\text{C}$ Case | 183 | $^{\circ}\text{C}$ |
| Median Lifetime (T_M) | 7.5 W Pdiss, CW | 7.82E7 | Hrs |
| Thermal Resistance (θ_{JC}) | Vds = 32V, Idq = 50mA | 14.2 | $^{\circ}\text{C}/\text{W}$ |
| Channel Temperature (T_{CH}) | 85 $^{\circ}\text{C}$ Case | 227 | $^{\circ}\text{C}$ |
| Median Lifetime (T_M) | 10 W Pdiss, CW | 1.54E6 | Hrs |
| Thermal Resistance (θ_{JC}) | Vds = 32V, Idq = 50mA | 15.5 | $^{\circ}\text{C}/\text{W}$ |
| Channel Temperature (T_{CH}) | 85 $^{\circ}\text{C}$ Case | 279 | $^{\circ}\text{C}$ |
| Median Lifetime (T_M) | 12.5 W Pdiss, CW | 3.35E4 | Hrs |

Notes:

1. Thermal resistance measured to bottom of package.

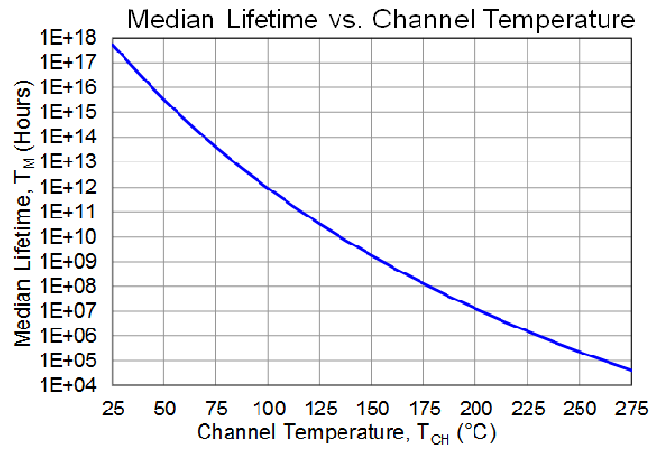
Thermal and Reliability Information - Pulsed ¹

| Parameter | Test Conditions | Value | Units |
|--------------------------------------|-----------------------------|--------|-----------------------------|
| Thermal Resistance (θ_{JC}) | Vds = 32V, Idq = 50mA | 8.4 | $^{\circ}\text{C}/\text{W}$ |
| Channel Temperature (T_{CH}) | 85 $^{\circ}\text{C}$ Case | 169 | $^{\circ}\text{C}$ |
| Median Lifetime (T_M) | 10 W Pdiss, 100uS PW, 20% | 3.18E8 | Hrs |
| Thermal Resistance (θ_{JC}) | Vds = 32V, Idq = 50mA | 8.7 | $^{\circ}\text{C}/\text{W}$ |
| Channel Temperature (T_{CH}) | 85 $^{\circ}\text{C}$ Case | 194 | $^{\circ}\text{C}$ |
| Median Lifetime (T_M) | 12.5 W Pdiss, 100uS PW, 20% | 2.73E7 | Hrs |
| Thermal Resistance (θ_{JC}) | Vds = 32V, Idq = 50mA | 9.1 | $^{\circ}\text{C}/\text{W}$ |
| Channel Temperature (T_{CH}) | 85 $^{\circ}\text{C}$ Case | 221 | $^{\circ}\text{C}$ |
| Median Lifetime (T_M) | 15 W Pdiss, 100uS PW, 20% | 2.54E6 | Hrs |

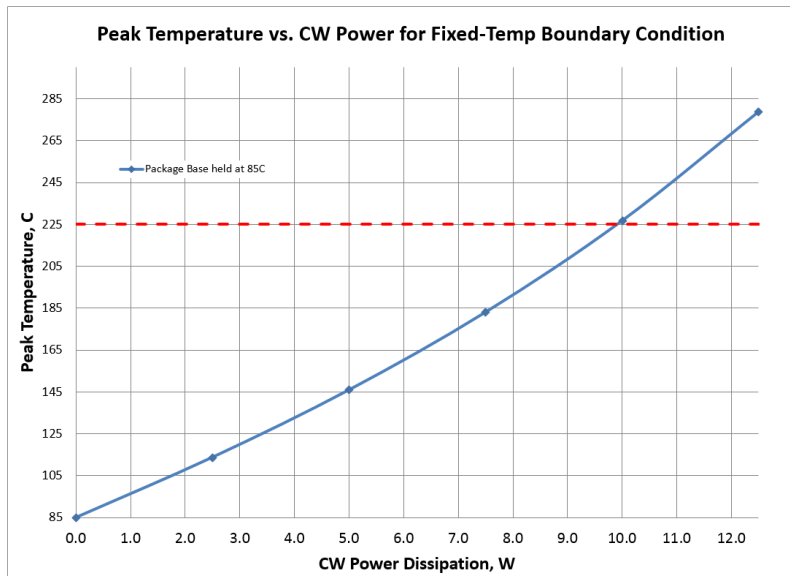
Notes:

1. Thermal resistance measured to bottom of package.

Median Lifetime



Maximum Channel Temperature



Load Pull Smith Charts ^(1, 2)

RF performance that the device typically exhibits when placed in the specified impedance environment. The impedances are not the impedances of the device, they are the impedances presented to the device via an RF circuit or load-pull system. The impedances listed follow an optimized trajectory to maintain high power and high efficiency.

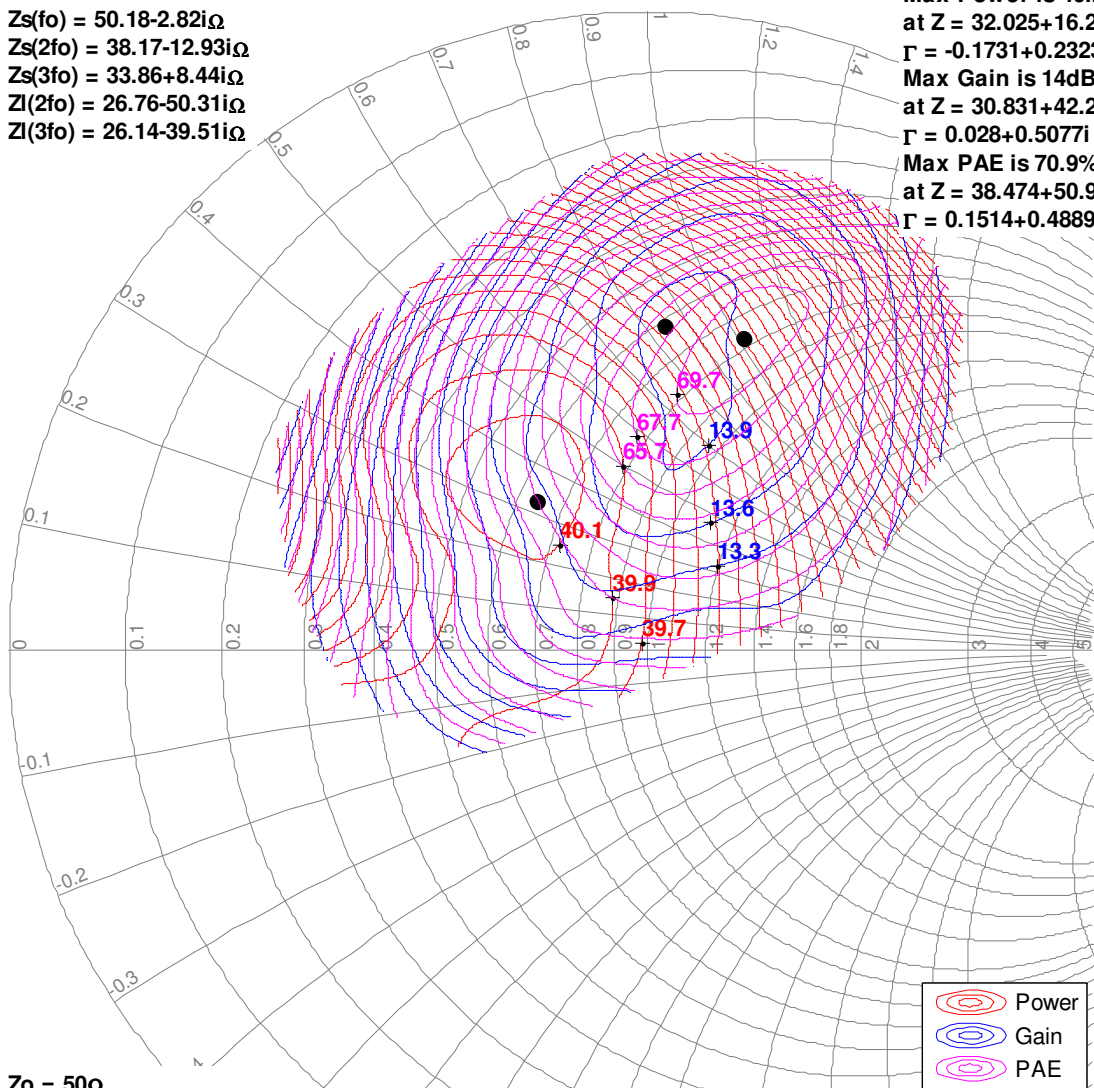
Notes:

1. 32V, 50mA, Pulsed signal with 100uS pulse width and 20% duty cycle. 3dB compression referenced at peak gain.
2. See page 18 for load pull and source pull reference planes.




1GHz, Load-pull

$Z_s(f_0) = 50.18 - 2.82i\Omega$
 $Z_s(2f_0) = 38.17 - 12.93i\Omega$
 $Z_s(3f_0) = 33.86 + 8.44i\Omega$
 $Z_l(2f_0) = 26.76 - 50.31i\Omega$
 $Z_l(3f_0) = 26.14 - 39.51i\Omega$

Max Power is 40.2dBm
 at $Z = 32.025 + 16.241i\Omega$
 $\Gamma = -0.1731 + 0.2323i$
 Max Gain is 14dB
 at $Z = 30.831 + 42.221i\Omega$
 $\Gamma = 0.028 + 0.5077i$
 Max PAE is 70.9%
 at $Z = 38.474 + 50.971i\Omega$
 $\Gamma = 0.1514 + 0.4889i$



$Z_0 = 50\Omega$
 Peak-gain referenced

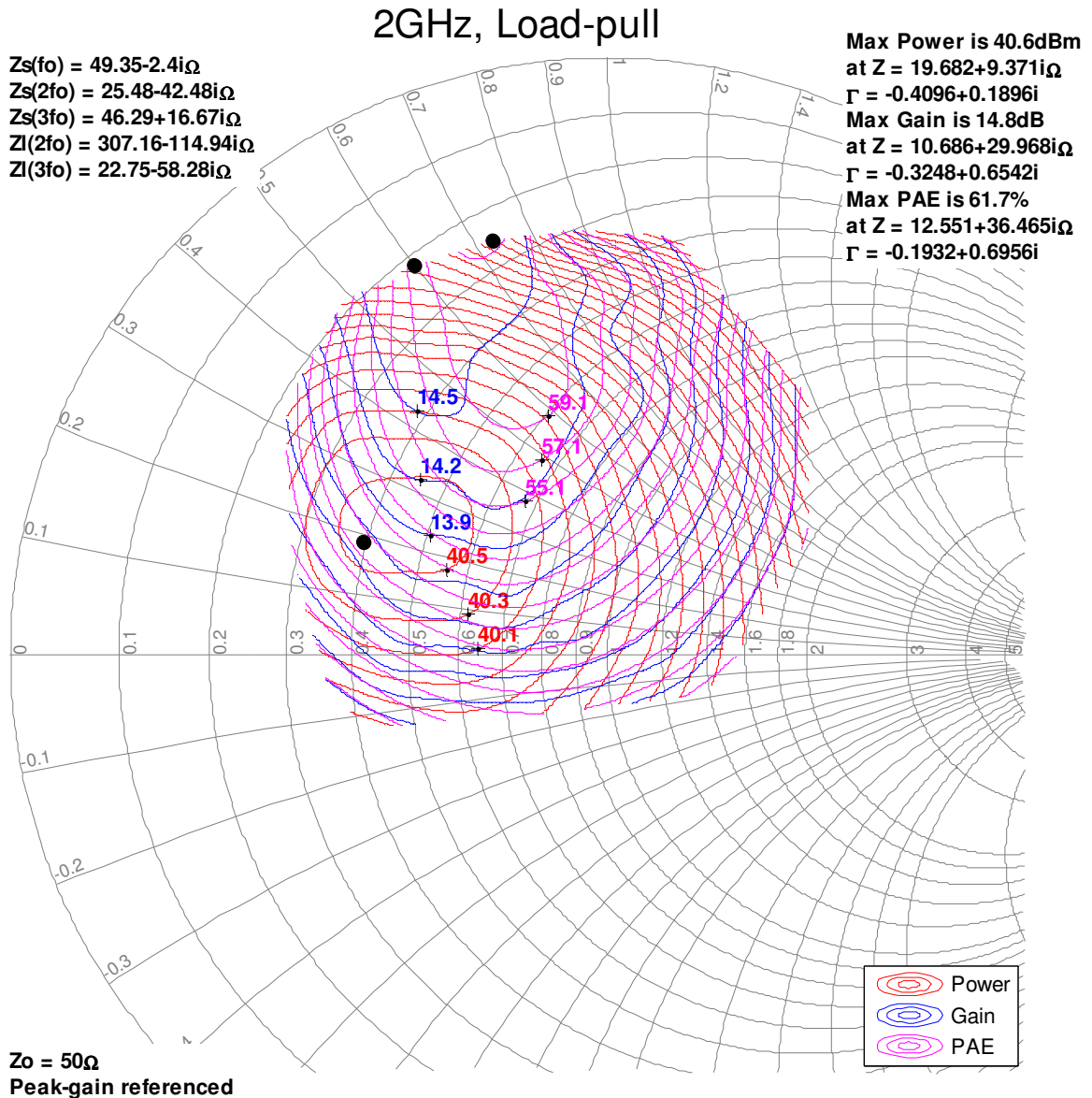
| | |
|---|-------|
|  | Power |
|  | Gain |
|  | PAE |

Load Pull Smith Charts ^(1, 2)

RF performance that the device typically exhibits when placed in the specified impedance environment. The impedances are not the impedances of the device, they are the impedances presented to the device via an RF circuit or load-pull system. The impedances listed follow an optimized trajectory to maintain high power and high efficiency.

Notes:

1. 32V, 50mA, Pulsed signal with 100uS pulse width and 20% duty cycle. 3dB compression referenced at peak gain.
2. See page 18 for load pull and source pull reference planes.



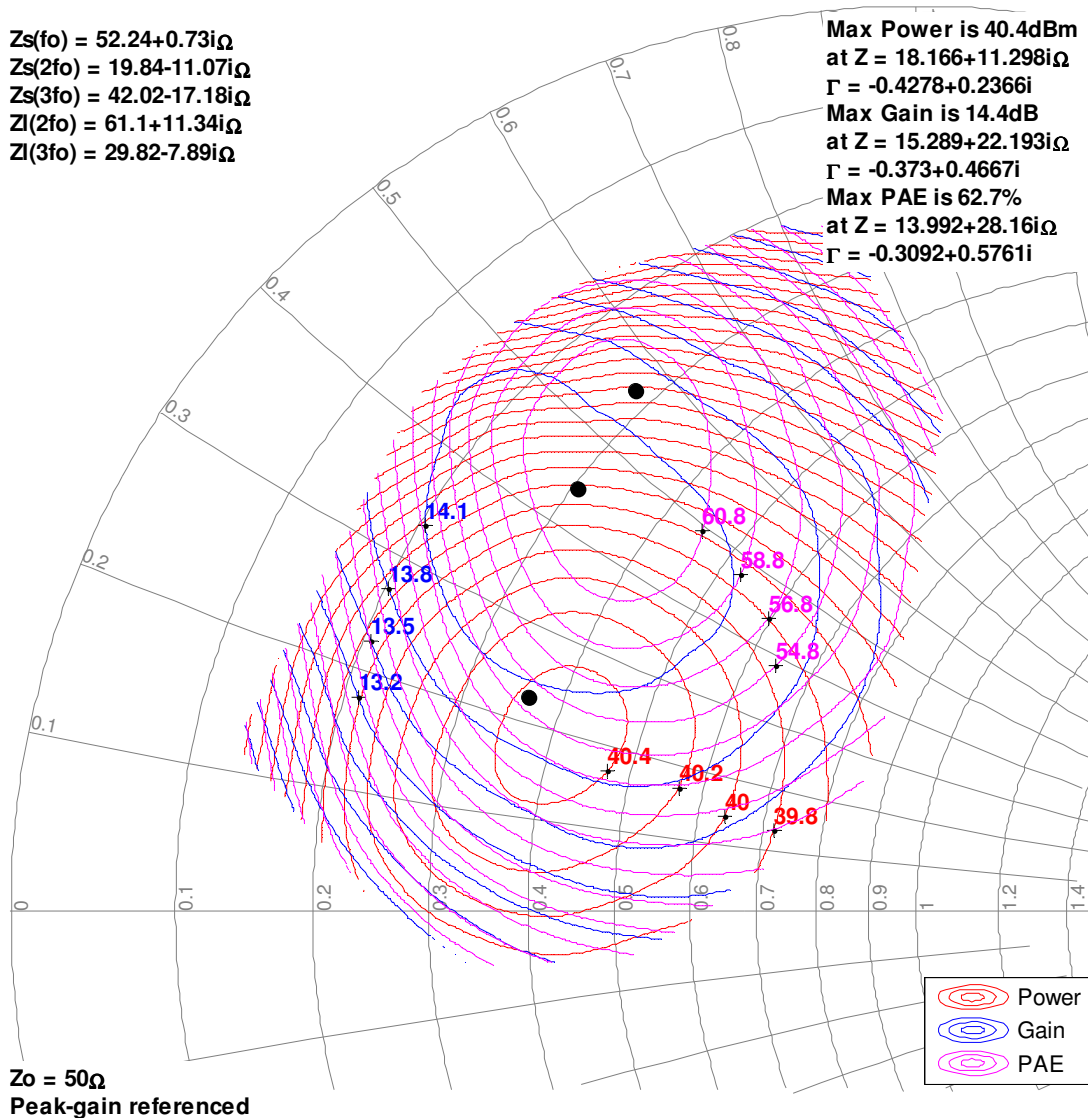
Load Pull Smith Charts ^(1, 2)

RF performance that the device typically exhibits when placed in the specified impedance environment. The impedances are not the impedances of the device, they are the impedances presented to the device via an RF circuit or load-pull system. The impedances listed follow an optimized trajectory to maintain high power and high efficiency.

Notes:

1. 32V, 50mA, Pulsed signal with 100uS pulse width and 20% duty cycle. 3dB compression referenced at peak gain.
2. See page 18 for load pull and source pull reference planes.

2.4GHz, Load-pull



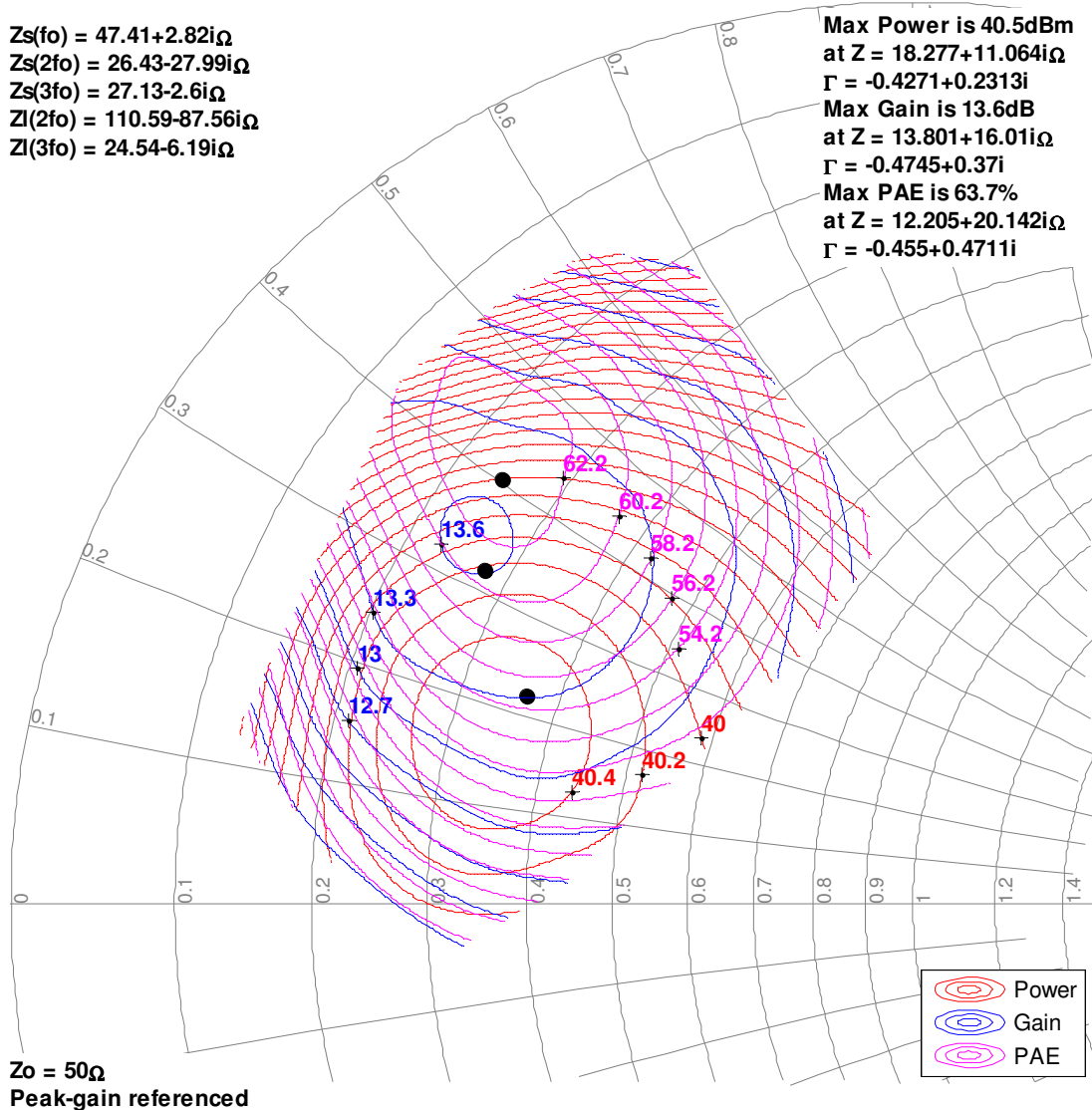
Load Pull Smith Charts ^(1, 2)

RF performance that the device typically exhibits when placed in the specified impedance environment. The impedances are not the impedances of the device, they are the impedances presented to the device via an RF circuit or load-pull system. The impedances listed follow an optimized trajectory to maintain high power and high efficiency.

Notes:

1. 32V, 50mA, Pulsed signal with 100uS pulse width and 20% duty cycle. 3dB compression referenced at peak gain.
2. See page 18 for load pull and source pull reference planes.

2.7GHz, Load-pull



Load Pull Smith Charts ^(1, 2)

RF performance that the device typically exhibits when placed in the specified impedance environment. The impedances are not the impedances of the device, they are the impedances presented to the device via an RF circuit or load-pull system. The impedances listed follow an optimized trajectory to maintain high power and high efficiency.

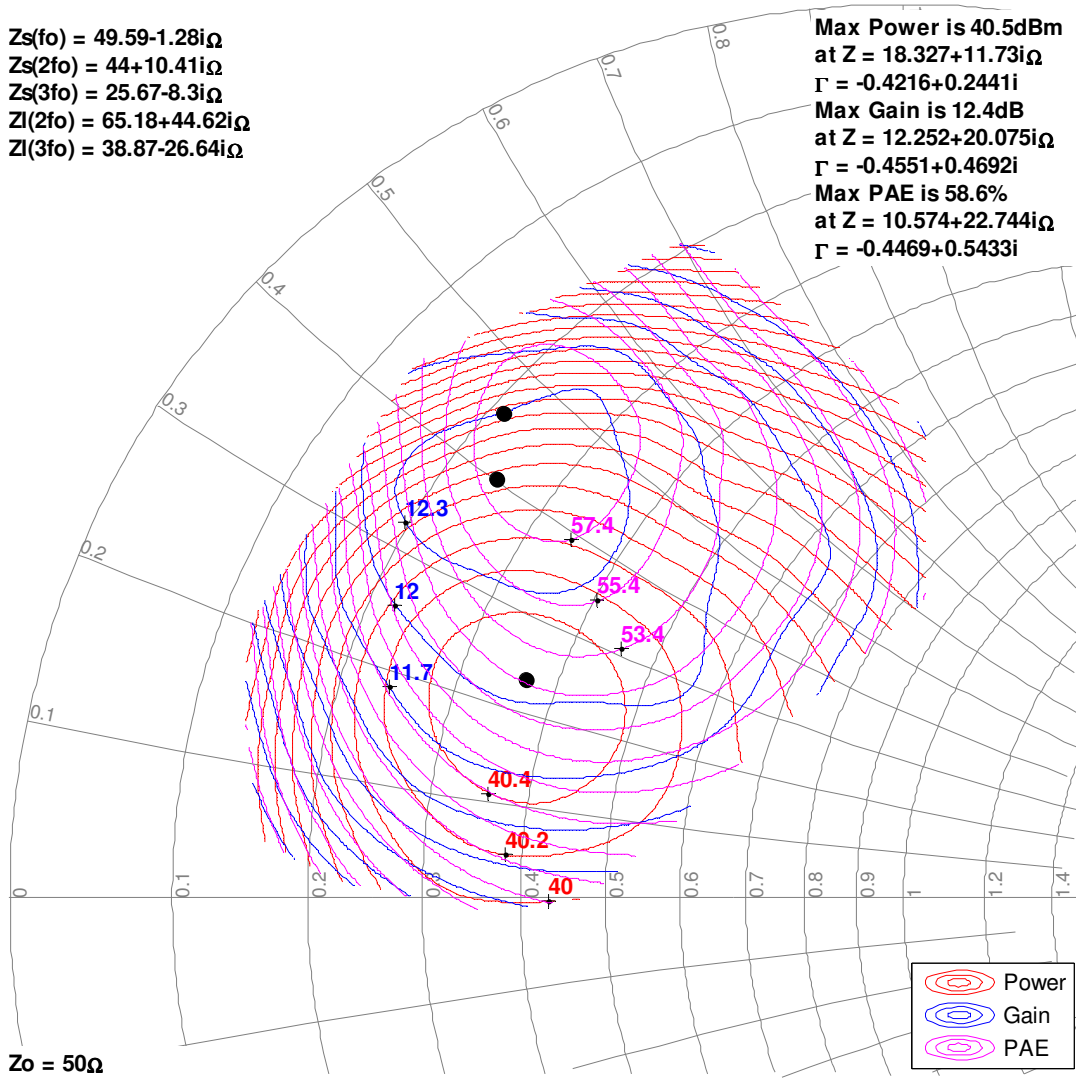
Notes:

1. 32V, 50mA, Pulsed signal with 100uS pulse width and 20% duty cycle. 3dB compression referenced at peak gain.
2. See page 18 for load pull and source pull reference planes.

3GHz, Load-pull

$Z_s(f_0) = 49.59 - 1.28i \Omega$
 $Z_s(2f_0) = 44 + 10.41i \Omega$
 $Z_s(3f_0) = 25.67 - 8.3i \Omega$
 $Z_l(2f_0) = 65.18 + 44.62i \Omega$
 $Z_l(3f_0) = 38.87 - 26.64i \Omega$

Max Power is 40.5dBm
 at $Z = 18.327 + 11.73i \Omega$
 $\Gamma = -0.4216 + 0.2441i$
Max Gain is 12.4dB
 at $Z = 12.252 + 20.075i \Omega$
 $\Gamma = -0.4551 + 0.4692i$
Max PAE is 58.6%
 at $Z = 10.574 + 22.744i \Omega$
 $\Gamma = -0.4469 + 0.5433i$

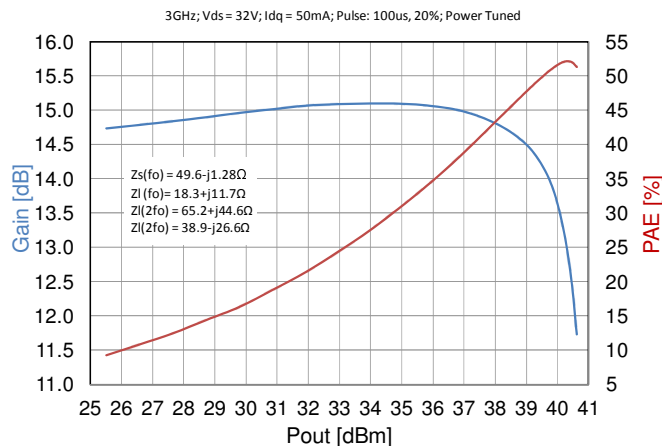
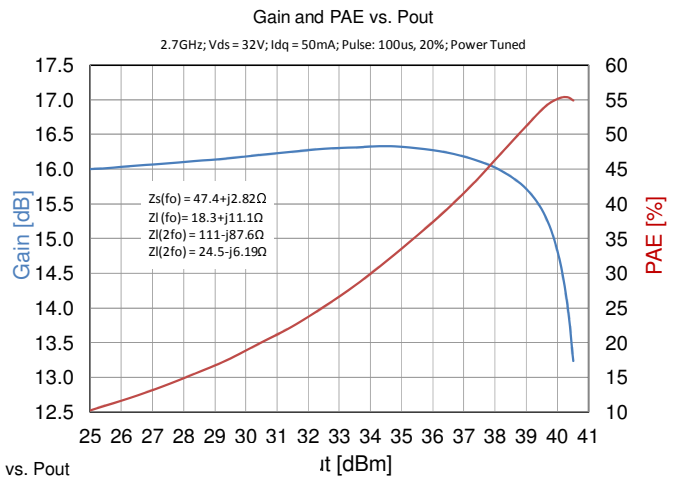
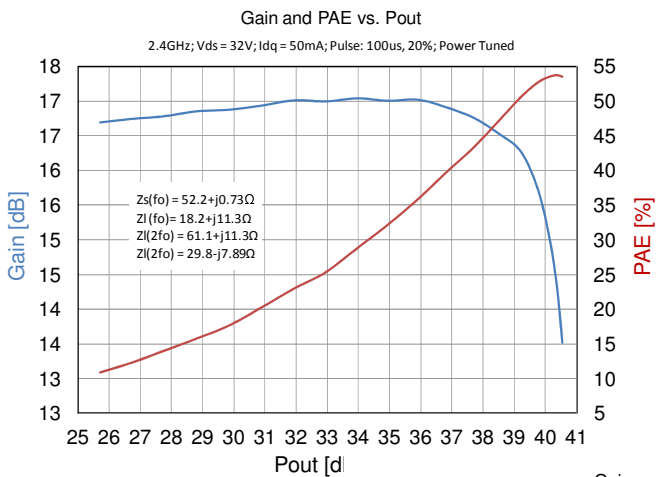
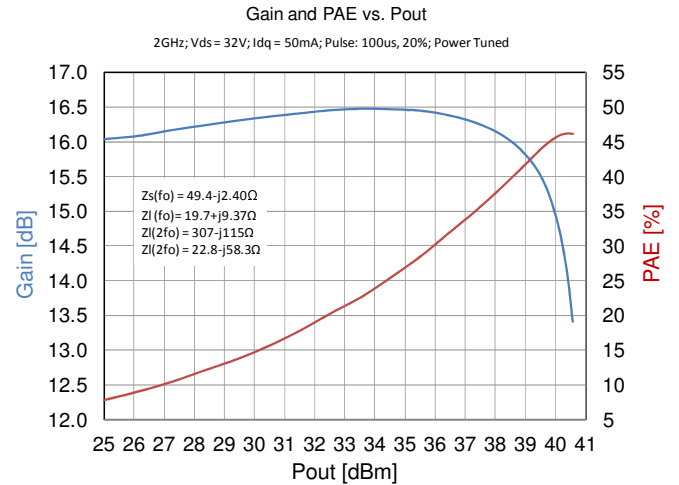
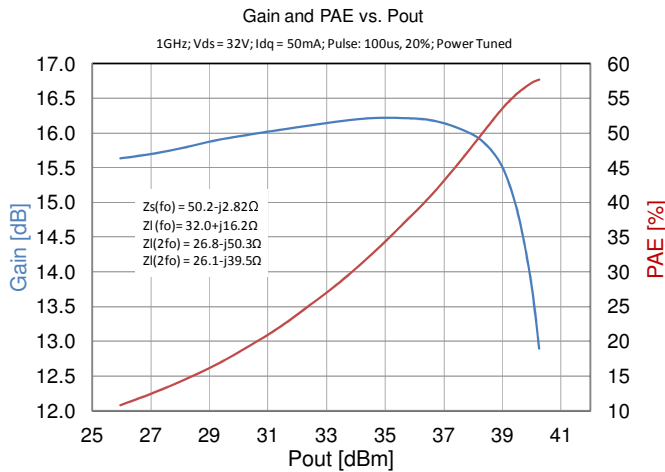


$Z_o = 50 \Omega$
 Peak-gain referenced

Typical Performance – Power Tuned^(1,2,3)

Notes:

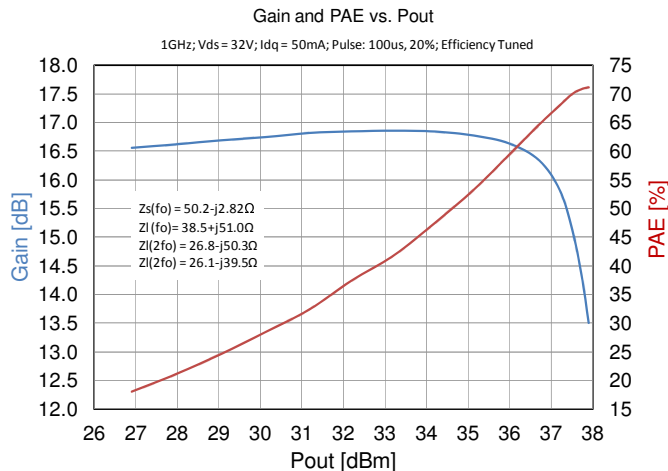
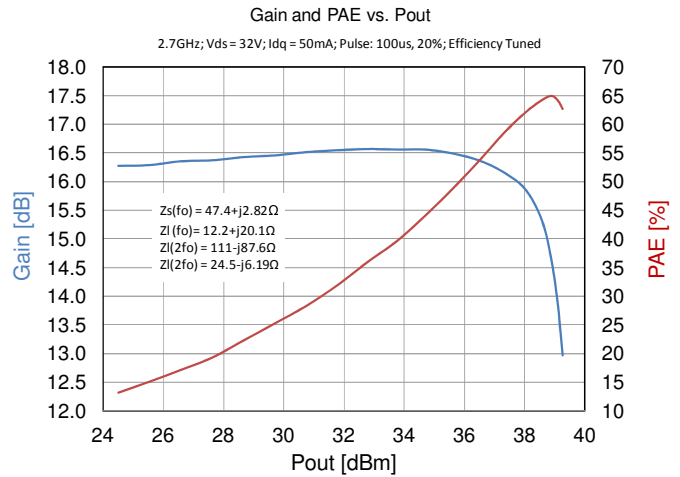
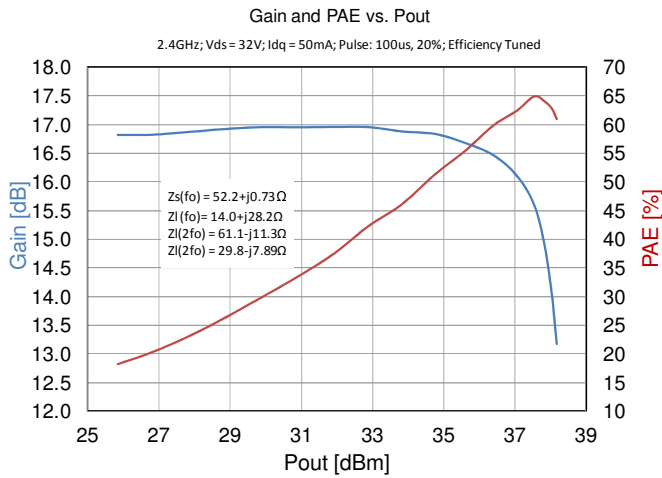
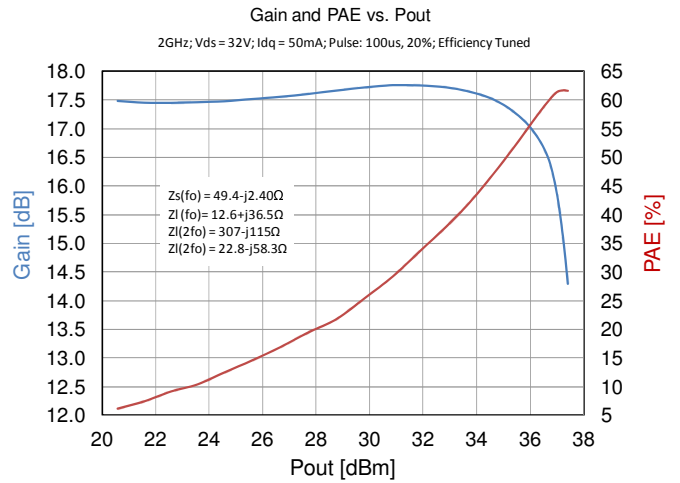
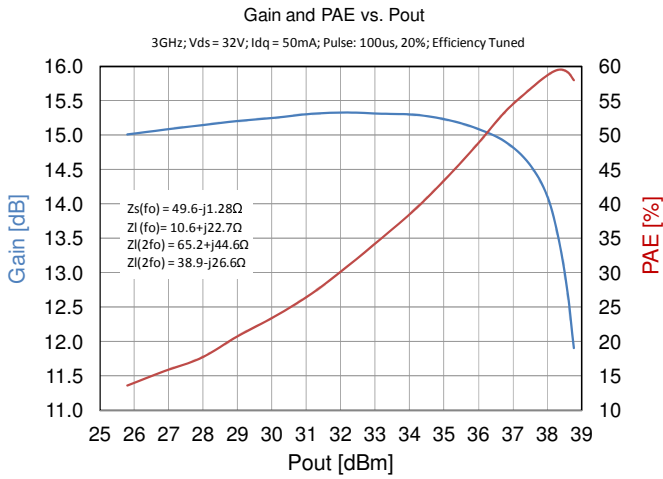
1. Pulsed signal with 100uS pulse width and 20% duty cycle
2. See page 18 for load pull and source pull reference planes.
3. Performance is measured at device reference planes.



Typical Performance – Efficiency Tuned^(1,2,3)

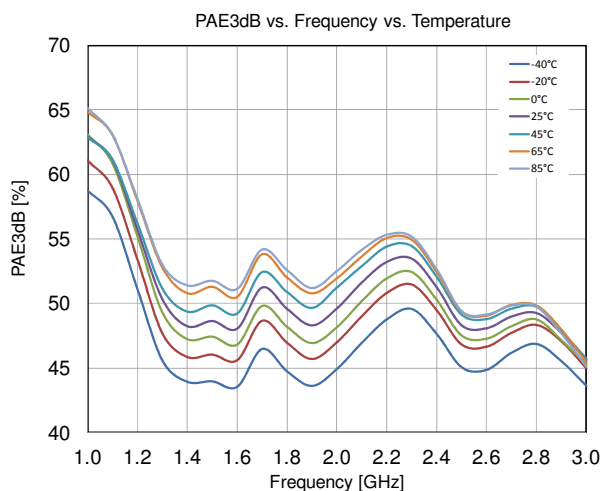
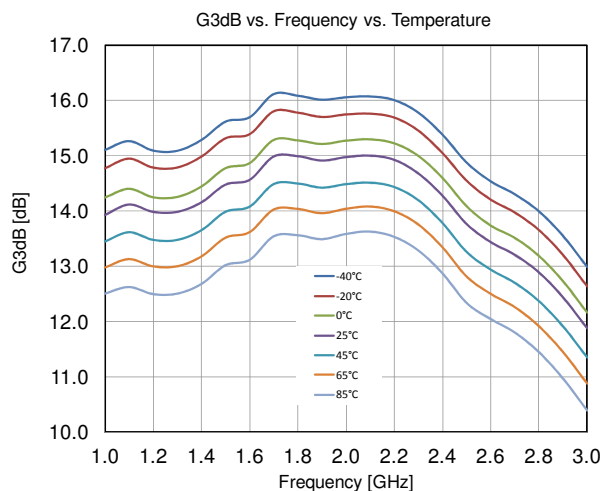
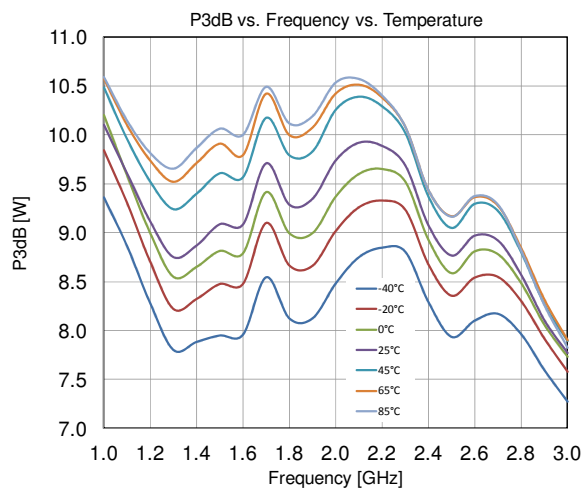
Notes:

1. Pulsed signal with 100µs pulse width and 20% duty cycle
2. See page 18 for load pull and source pull reference planes.



Evaluation Board Performance Over Temperature (1, 2)

Performance measured on TriQuint's 0.5 GHz to 3 GHz Evaluation Board

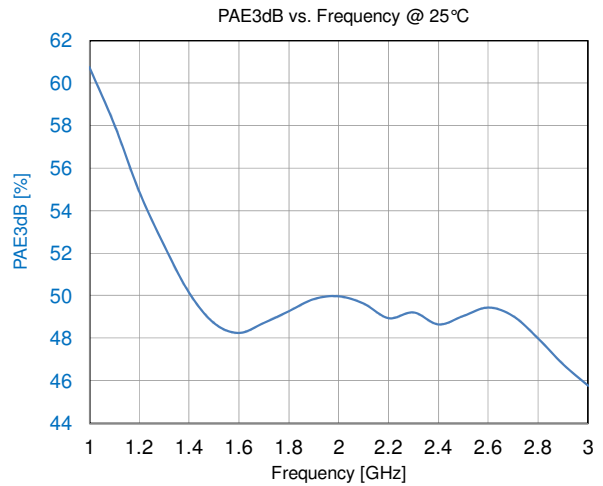
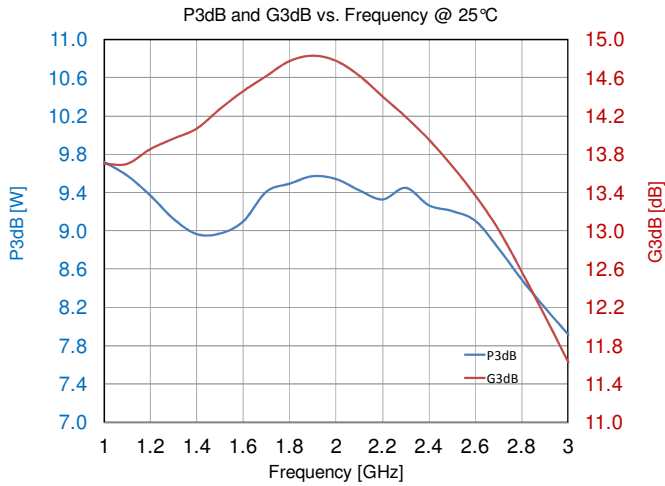


Notes:

1. Test Conditions: $V_{DS} = 32\text{ V}$, $I_{DQ} = 50\text{ mA}$
2. Test Signal: Pulse Width = 100 μs , Duty Cycle = 20%

Evaluation Board Performance At 25 °C^(1, 2)

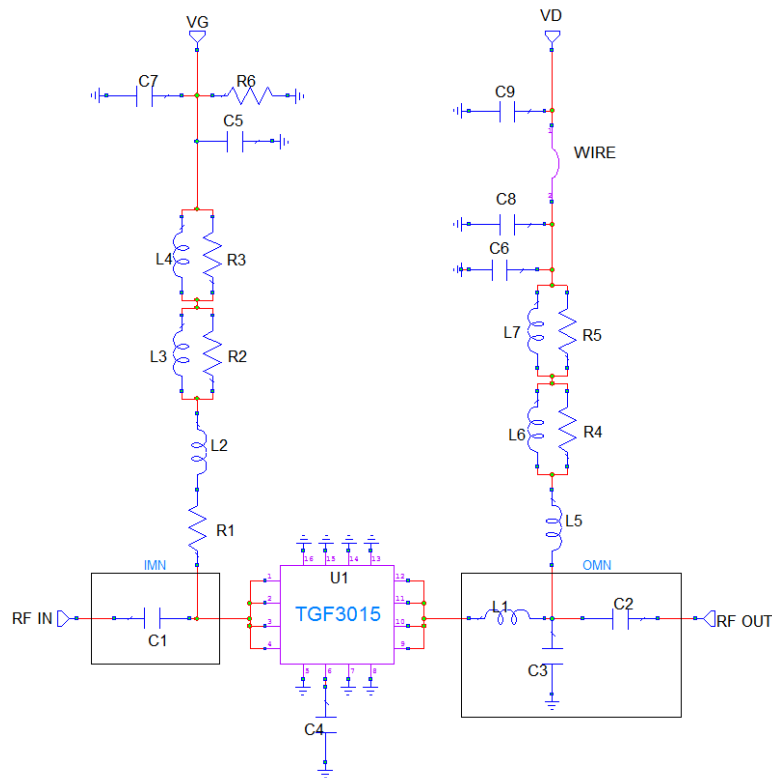
Performance measured on TriQuint's 0.5 GHz to 3.0 GHz Evaluation Board



Notes:

1. Test Conditions: $V_{DS} = 32\text{ V}$, $I_{DQ} = 50\text{ mA}$, 25 °C
2. Test Signal: Pulse Width = $100\text{ }\mu\text{s}$, Duty Cycle = 20 %

Application Circuit



Bias-up Procedure

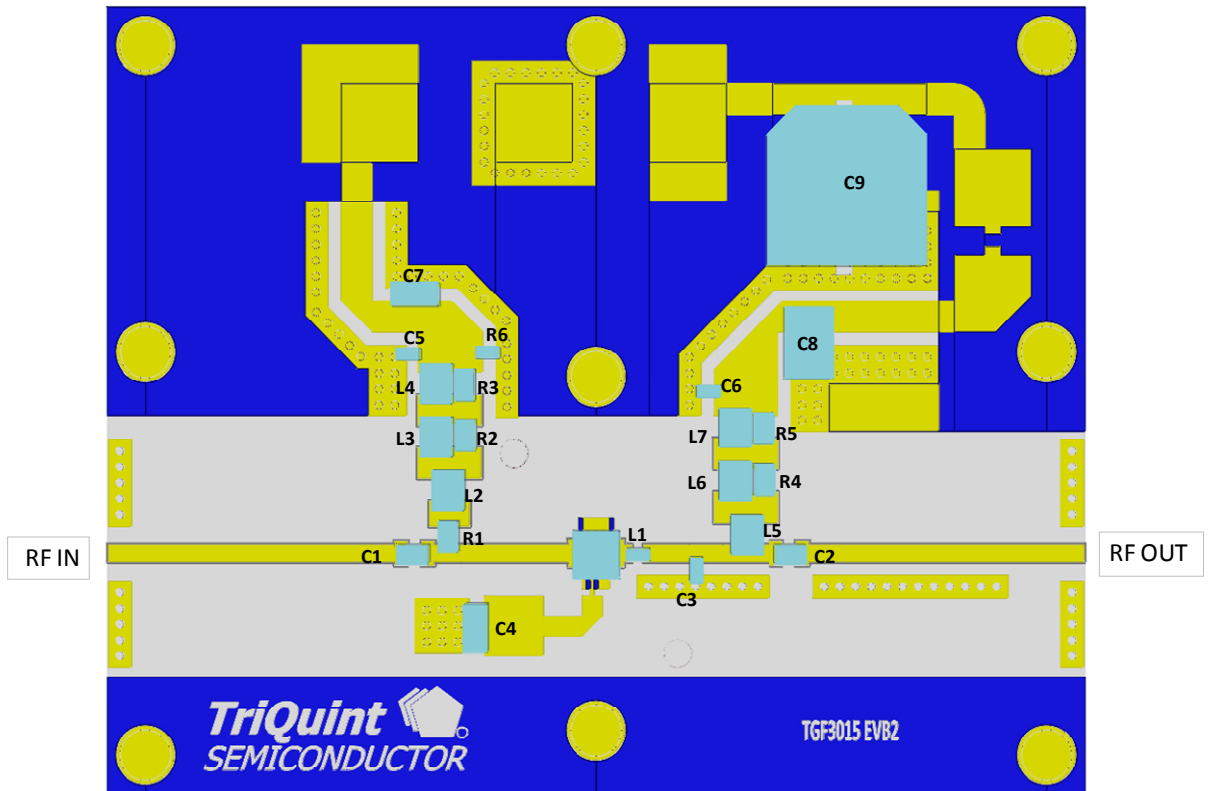
- Set gate voltage (V_G) to -5.0V
- Set drain voltage (V_D) to 32 V
- Slowly increase V_G until quiescent I_D is 50 mA.
- Apply RF signal

Bias-down Procedure

- Turn off RF signal
- Turn off V_D and wait 1 second to allow drain capacitor dissipation
- Turn off V_G

Evaluation Board Layout

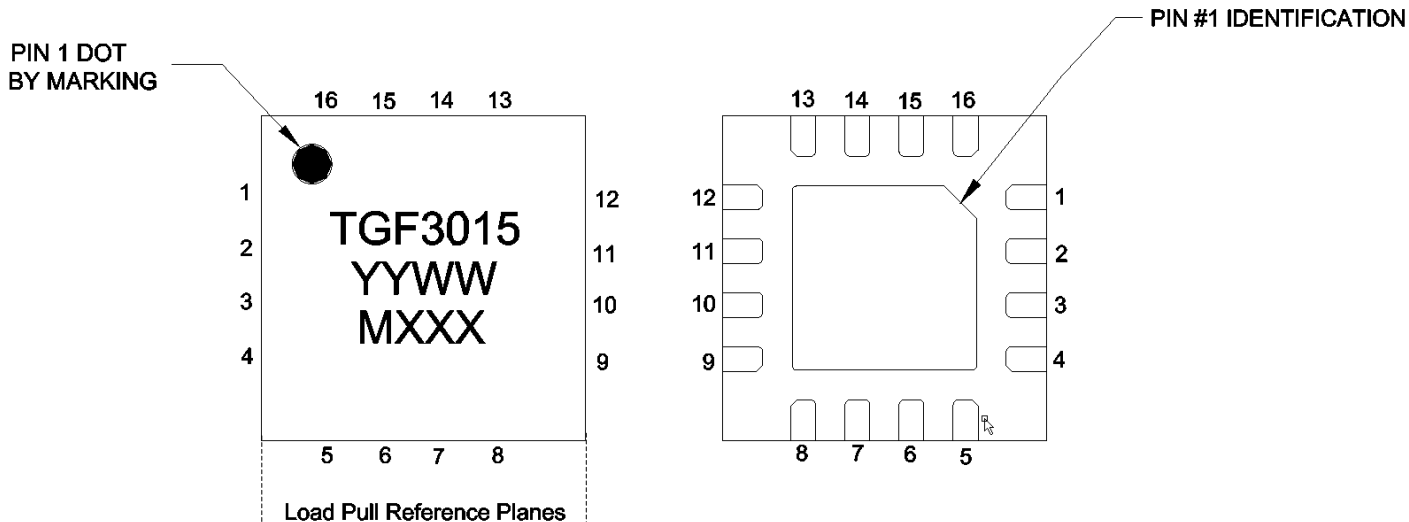
Top RF layer is 0.020" thick Rogers RO4350B, $\epsilon_r = 3.48$. The pad pattern shown has been developed and tested for optimized assembly at TriQuint Semiconductor. The PCB land pattern has been developed to accommodate lead and package tolerances.



Bill of Materials

| Reference Design | Value | Qty | Manufacturer | Part Number |
|------------------|--------|-----|-----------------|---------------------|
| R1 | 500Ω | 1 | | Generic 0603 |
| R2, R3, R4, R5 | 400Ω | 4 | | Generic 0603 |
| R6 | 1kΩ | 1 | | Generic 0603 |
| C1, C2, C5, C6 | 2400pF | 4 | Dielectric Labs | C08BL242X-5UN-X0B |
| C3 | 0.5pF | 1 | ATC | 600S005BT250XT |
| C4, C7 | 10uF | 2 | TDK | C1632X5R0J106M130AC |
| C8 | 1uF | 1 | AVX | 18121C105KAT2A |
| C9 | 220uF | | United Chemicon | EMVY500ADA221MJA0G |
| L1 | 1.6nH | 1 | CoilCraft | 0603HC-1N6XJLU |
| L2, L5 | 82nH | 2 | CoilCraft | 1008CS-820XGLB |
| L3, L6 | 100nH | 2 | CoilCraft | 1008CS-101XGLB |
| L4, L7 | 900nH | 2 | CoilCraft | 1008AF-901XJLB |

Pin Layout



Pin Description

| Pin | Symbol | Description |
|---------------|----------------|--|
| 9, 10, 11, 12 | V_D / RF OUT | Drain voltage / RF Output to be matched to 50 ohms; see EVB Layout on page 17 as an example. |
| 3 | V_G / RF IN | Gate voltage / RF Input to be matched to 50 ohms; see EVB Layout on page 17 as an example. |
| 6 | Off-Chip Cap | Off-chip cap to extend low frequency gain. |
| Back side | Source | Source connected to ground |

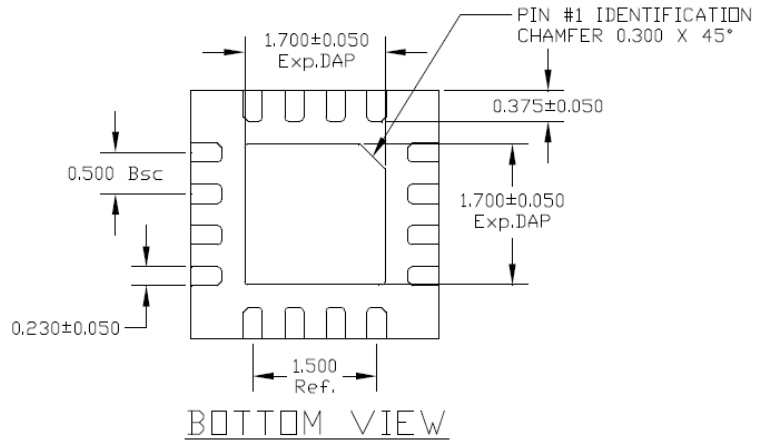
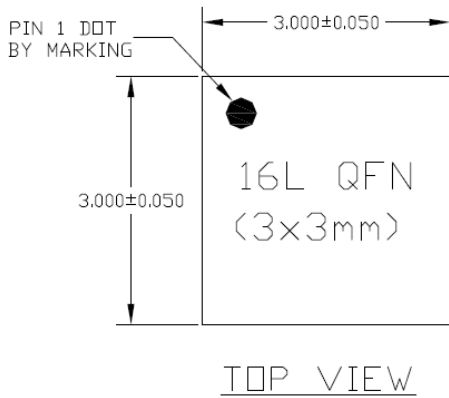
Notes:

Thermal resistance measured to back side of package

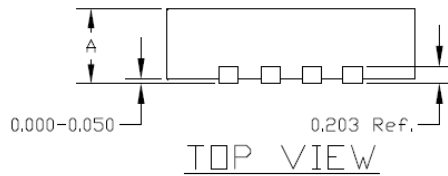
The TGF3015-SM will be marked with the "TGF3015" designator and a lot code marked below the part designator. The "YY" represents the last two digits of the calendar year the part was manufactured, the "WW" is the work week of the assembly lot start, and the "MXXX" is the production lot number.

Mechanical Information

All dimensions are in millimeters.



| | | |
|---|------|-------|
| | | QFN |
| A | MAX. | 0.900 |
| | NOM. | 0.850 |
| | MIN. | 0.800 |



Note:

Unless otherwise noted, all dimension tolerances are +/-0.127 mm.
 This package is lead-free/RoHS-compliant. The plating material on the leads is NiAu. It is compatible with both lead-free (maximum 260 °C reflow temperature) and tin-lead (maximum 245 °C reflow temperature) soldering processes.

Product Compliance Information

ESD Sensitivity Ratings



Caution! ESD-Sensitive Device

ESD Rating: TBD
 Value: Passes \geq TBD V min.
 Test: Human Body Model (HBM)
 Standard: JEDEC Standard JESD22-A114

MSL Rating

The part is rated Moisture Sensitivity Level 3 at 260°C per JEDEC standard IPC/JEDEC J-STD-020.

ECCN

US Department of Commerce EAR99

Solderability

Compatible with the latest version of J-STD-020, Lead free solder, 260° C

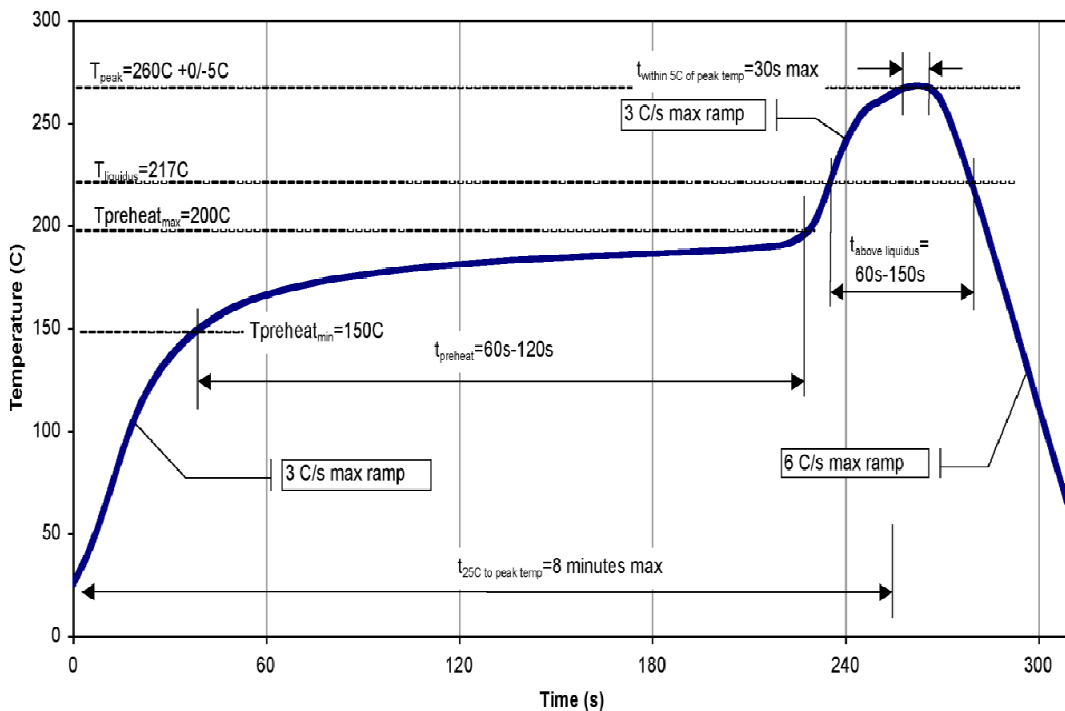
RoHs Compliance

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A (C₁₅H₁₂Br₄O₂) Free
- PFOS Free
- SVHC Free

Recommended Soldering Temperature Profile



Contact Information

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